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BFP740FESD

Robust Low Noise Silicon Germanium Bipolar RF Transistor

Data Sheet

Revision 1.2, 2012-10-11

Edition 2012-10-11

**Published by
Infineon Technologies AG
81726 Munich, Germany**

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BFP740FESD, Robust Low Noise Silicon Germanium Bipolar RF Transistor

Revision History: 2012-10-11. Revision 1.2

Page	Subjects (major changes since last revision)
	This data sheet replaces the revision from 2010-06-29. The product itself has not been changed and the device characteristics remain unchanged. Only the product description and information available in the data sheet has been expanded and updated.

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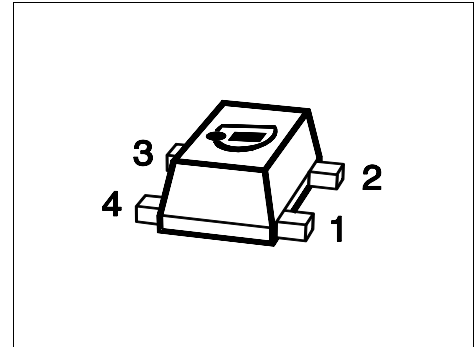
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1 Product Brief

The BFP740FESD is a very low noise wideband NPN bipolar RF transistor. The device is based on Infineon's reliable high volume silicon germanium carbon (SiGe:C) heterojunction bipolar technology. The collector design supports voltages up to $V_{CE0} = 4.2$ V and currents up to $I_C = 45$ mA. The device is especially suited for mobile applications in which low power consumption is a key requirement. The typical transition frequency is approximately 47 GHz, hence the device offers high power gain at frequencies up to 12 GHz in amplifier applications. The transistor is fitted with internal protection circuits, which enhance the robustness against electrostatic discharge (ESD) and high levels of RF input power. The device is housed in a thin small flat plastic package with visible leads.

2 Features

- Robust very low noise amplifier based on Infineon's reliable, high volume SiGe:C wafer technology
- 2 kV ESD robustness (HBM) due to integrated protection circuits
- High maximum RF input power of 21 dBm
- 0.60 dB minimum noise figure typical at 2.4 GHz, 0.8 dB at 5.5 GHz, 6 mA
- 26 dB maximum gain G_{ms} typical at 2.4 GHz, 20.5 dB G_{ma} at 5.5 GHz, 25 mA
- 23.5 dBm OIP_3 typical at 5.5 GHz, 25 mA
- Thin small flat Pb-free (RoHS compliant) and halogen-free package with visible leads
- Qualification report according to AEC-Q101 available



Applications

As Low Noise Amplifier (LNA) in

- Mobile, portable and fixed connectivity applications: WLAN 802.11a/b/g/n, WiMax 2.5/3.5/5 GHz, UWB, Bluetooth
- Satellite communication systems: Navigation systems (GPS, Glonass), satellite radio (SDARs, DAB) and C-band LNB
- Multimedia applications such as mobile/portable TV, CATV, FM Radio
- 3G/4G UMTS/LTE mobile phone applications
- ISM applications like RKE, AMR and Zigbee, as well as for emerging wireless applications

As discrete active mixer, amplifier in VCOs and buffer amplifier

Attention: ESD (Electrostatic discharge) sensitive device, observe handling precautions

Product Name	Package	Pin Configuration				Marking
		1 = B	2 = E	3 = C	4 = E	
BFP740FESD	TSFP-4-1	1 = B	2 = E	3 = C	4 = E	T7s

3 Maximum Ratings

Table 3-1 Maximum Ratings at $T_A = 25\text{ °C}$ (unless otherwise specified)

Parameter	Symbol	Values		Unit	Note / Test Condition
		Min.	Max.		
Collector emitter voltage	V_{CEO}	–	4.2	V	Open base $T_A = 25\text{ °C}$
		–	3.7	V	$T_A = -55\text{ °C}$
Collector emitter voltage ¹⁾	V_{CBO}	–	4.9	V	Open emitter $T_A = 25\text{ °C}$
		–	4.4	V	$T_A = -55\text{ °C}$
Collector emitter voltage ²⁾	V_{CES}	–	4.2	V	E-B short circuited $T_A = 25\text{ °C}$
		–	3.7	V	$T_A = -55\text{ °C}$
Base current ³⁾	I_B	-10	5	mA	–
Collector current	I_C	–	45	mA	–
RF input power ⁴⁾	P_{RFIn}	–	21	dBm	–
ESD stress pulse ⁵⁾	V_{ESD}	-2	2	kV	HBM, all pins, acc. to JESD22-A114
Total power dissipation ⁶⁾	P_{tot}	–	160	mW	$T_S \leq 100\text{ °C}$
Junction temperature	T_J	–	150	°C	–
Storage temperature	T_{Stg}	-55	150	°C	–

1) Low V_{CBO} due to integrated protection circuits

2) V_{CES} is identical to V_{CEO} due to integrated protection circuits.

3) Sustainable reverse bias current is high due to integrated protection circuits.

4) RF input power is high due to integrated protection circuits.

5) ESD robustness is high due to integrated protection circuits.

6) T_S is the soldering point temperature. T_S is measured on the emitter lead at the soldering point of the pcb.

Attention: Stresses above the max. values listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the integrated circuit.

4 Thermal Characteristics

Table 4-1 Thermal Resistance

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Junction - soldering point ¹⁾	R_{thJS}	–	315	–	K/W	–

1)For the definition of R_{thJS} please refer to Application Note AN077 (Thermal Resistance Calculation)

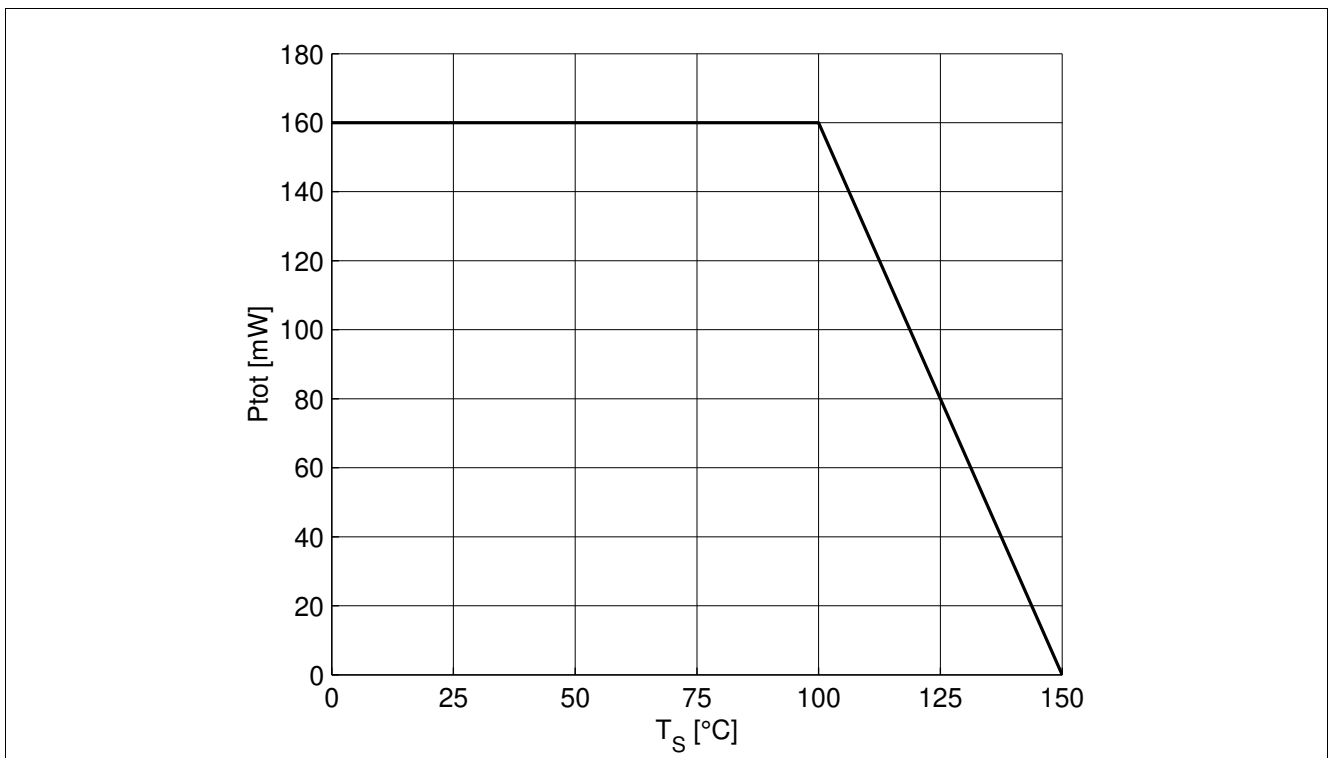


Figure 4-1 Total Power Dissipation $P_{tot} = f(T_s)$

5 Electrical Characteristics

5.1 DC Characteristics

Table 5-1 DC Characteristics at $T_A = 25\text{ °C}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Collector emitter breakdown voltage	$V_{(BR)CEO}$	4.2	4.7	–	V	$I_C = 1\text{ mA}$, $I_B = 0$ Open base
Collector emitter leakage current	I_{CES}	–	–	400	nA	$V_{CE} = 2\text{ V}$, $V_{BE} = 0$ E-B short circuited
Collector base leakage current	I_{CBO}	–	–	400	nA	$V_{CB} = 2\text{ V}$, $I_E = 0$ Open emitter
Emitter base leakage current	I_{EBO}	–	–	10	μA	$V_{EB} = 0.5\text{ V}$, $I_C = 0$ Open collector
DC current gain	h_{FE}	160	250	400		$V_{CE} = 3\text{ V}$, $I_C = 25\text{ mA}$ Pulse measured

5.2 General AC Characteristics

Table 5-2 General AC Characteristics at $T_A = 25\text{ °C}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Transition frequency	f_T	–	47	–	GHz	$V_{CE} = 3\text{ V}$, $I_C = 25\text{ mA}$ $f = 1\text{ GHz}$
Collector base capacitance	C_{CB}	–	0.08	–	pF	$V_{CB} = 3\text{ V}$, $V_{BE} = 0$ $f = 1\text{ MHz}$ Emitter grounded
Collector emitter capacitance	C_{CE}	–	0.4	–	pF	$V_{CE} = 3\text{ V}$, $V_{BE} = 0$ $f = 1\text{ MHz}$ Base grounded
Emitter base capacitance	C_{EB}	–	0.5	–	pF	$V_{EB} = 0.4\text{ V}$, $V_{CB} = 0$ $f = 1\text{ MHz}$ Collector grounded

5.3 Frequency Dependent AC Characteristics

Measurement setup is a test fixture with Bias T's in a 50 Ω system, $T_A = 25\text{ °C}$

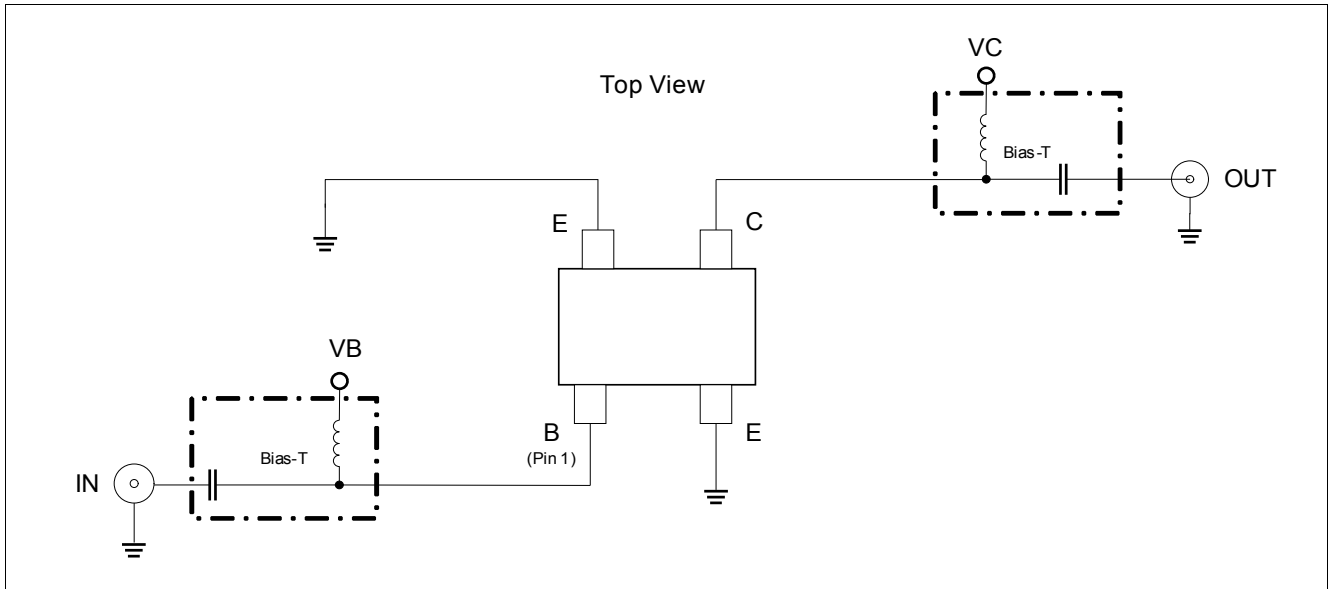


Figure 5-1 BFP740FESD Testing Circuit

Table 5-3 AC Characteristics, $V_{CE} = 3\text{ V}$, $f = 150\text{ MHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Maximum power gain					dB	
Low noise operation point	G_{ms}	–	33.5	–		$I_C = 6\text{ mA}$
High linearity operation point	G_{ms}	–	39	–		$I_C = 25\text{ mA}$
Transducer gain					dB	$Z_S = Z_L = 50\text{ }\Omega$
Low noise operation point	S_{21}	–	25	–		$I_C = 6\text{ mA}$
High linearity operation point	S_{21}	–	34	–		$I_C = 25\text{ mA}$
Minimum noise figure					dB	$Z_S = Z_{opt}$
Minimum noise figure	NF_{min}	–	0.5	–		$I_C = 6\text{ mA}$
Associated gain	G_{ass}	–	31	–		$I_C = 6\text{ mA}$
Linearity					dBm	$Z_S = Z_L = 50\text{ }\Omega$
1 dB gain compression point	OP_{1dB}	–	10	–		$I_C = 25\text{ mA}$
3rd order intercept point	OIP_3	–	23.5	–		$I_C = 25\text{ mA}$

Electrical Characteristics
Table 5-4 AC Characteristics, $V_{CE} = 3\text{ V}$, $f = 450\text{ MHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Maximum power gain					dB	
Low noise operation point	G_{ms}	–	29	–		$I_C = 6\text{ mA}$
High linearity operation point	G_{ms}	–	34	–		$I_C = 25\text{ mA}$
Transducer gain					dB	$Z_S = Z_L = 50\ \Omega$
Low noise operation point	S_{21}	–	24.5	–		$I_C = 6\text{ mA}$
High linearity operation point	S_{21}	–	32.5	–		$I_C = 25\text{ mA}$
Minimum noise figure					dB	$Z_S = Z_{opt}$
Minimum noise figure	NF_{min}	–	0.5	–		$I_C = 6\text{ mA}$
Associated gain	G_{ass}	–	29	–		$I_C = 6\text{ mA}$
Linearity					dBm	$Z_S = Z_L = 50\ \Omega$
1 dB gain compression point	OP_{1dB}	–	10	–		$I_C = 25\text{ mA}$
3rd order intercept point	OIP_3	–	23.5	–		$I_C = 25\text{ mA}$

Table 5-5 AC Characteristics, $V_{CE} = 3\text{ V}$, $f = 900\text{ MHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Maximum power gain					dB	
Low noise operation point	G_{ms}	–	26	–		$I_C = 6\text{ mA}$
High linearity operation point	G_{ms}	–	30.5	–		$I_C = 25\text{ mA}$
Transducer gain					dB	$Z_S = Z_L = 50\ \Omega$
Low noise operation point	S_{21}	–	24	–		$I_C = 6\text{ mA}$
High linearity operation point	S_{21}	–	29.5	–		$I_C = 25\text{ mA}$
Minimum noise figure					dB	$Z_S = Z_{opt}$
Minimum noise figure	NF_{min}	–	0.55	–		$I_C = 6\text{ mA}$
Associated gain	G_{ass}	–	26.5	–		$I_C = 6\text{ mA}$
Linearity					dBm	$Z_S = Z_L = 50\ \Omega$
1 dB gain compression point	OP_{1dB}	–	10	–		$I_C = 25\text{ mA}$
3rd order intercept point	OIP_3	–	24	–		$I_C = 25\text{ mA}$

Table 5-6 AC Characteristics, $V_{CE} = 3\text{ V}$, $f = 1.5\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Maximum power gain					dB	
Low noise operation point	G_{ms}	–	23.5	–		$I_C = 6\text{ mA}$
High linearity operation point	G_{ms}	–	28	–		$I_C = 25\text{ mA}$
Transducer gain					dB	$Z_S = Z_L = 50\ \Omega$
Low noise operation point	S_{21}	–	22	–		$I_C = 6\text{ mA}$
High linearity operation point	S_{21}	–	26	–		$I_C = 25\text{ mA}$
Minimum noise figure					dB	$Z_S = Z_{opt}$
Minimum noise figure	NF_{min}	–	0.55	–		$I_C = 6\text{ mA}$
Associated gain	G_{ass}	–	24	–		$I_C = 6\text{ mA}$
Linearity					dBm	$Z_S = Z_L = 50\ \Omega$
1 dB gain compression point	OP_{1dB}	–	10	–		$I_C = 25\text{ mA}$
3rd order intercept point	OIP_3	–	24	–		$I_C = 25\text{ mA}$

Table 5-7 AC Characteristics, $V_{CE} = 3\text{ V}$, $f = 1.9\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Maximum power gain					dB	
Low noise operation point	G_{ms}	–	22.5	–		$I_C = 6\text{ mA}$
High linearity operation point	G_{ms}	–	27	–		$I_C = 25\text{ mA}$
Transducer gain					dB	$Z_S = Z_L = 50\ \Omega$
Low noise operation point	S_{21}	–	21	–		$I_C = 6\text{ mA}$
High linearity operation point	S_{21}	–	24.5	–		$I_C = 25\text{ mA}$
Minimum noise figure					dB	$Z_S = Z_{opt}$
Minimum noise figure	NF_{min}	–	0.55	–		$I_C = 6\text{ mA}$
Associated gain	G_{ass}	–	22	–		$I_C = 6\text{ mA}$
Linearity					dBm	$Z_S = Z_L = 50\ \Omega$
1 dB gain compression point	OP_{1dB}	–	10	–		$I_C = 25\text{ mA}$
3rd order intercept point	OIP_3	–	24.5	–		$I_C = 25\text{ mA}$

Electrical Characteristics
Table 5-8 AC Characteristics, $V_{CE} = 3\text{ V}$, $f = 2.4\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Maximum power gain					dB	
Low noise operation point	G_{ms}	–	22	–		$I_C = 6\text{ mA}$
High linearity operation point	G_{ms}	–	26	–		$I_C = 25\text{ mA}$
Transducer gain					dB	$Z_S = Z_L = 50\ \Omega$
Low noise operation point	S_{21}	–	20	–		$I_C = 6\text{ mA}$
High linearity operation point	S_{21}	–	22.5	–		$I_C = 25\text{ mA}$
Minimum noise figure					dB	$Z_S = Z_{opt}$
Minimum noise figure	NF_{min}	–	0.6	–		$I_C = 6\text{ mA}$
Associated gain	G_{ass}	–	20.5	–		$I_C = 6\text{ mA}$
Linearity					dBm	$Z_S = Z_L = 50\ \Omega$
1 dB gain compression point	OP_{1dB}	–	10	–		$I_C = 25\text{ mA}$
3rd order intercept point	OIP_3	–	24.5	–		$I_C = 25\text{ mA}$

Table 5-9 AC Characteristics, $V_{CE} = 3\text{ V}$, $f = 3.5\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Maximum power gain					dB	
Low noise operation point	G_{ms}	–	20.5	–		$I_C = 6\text{ mA}$
High linearity operation point	G_{ms}	–	24	–		$I_C = 25\text{ mA}$
Transducer gain					dB	$Z_S = Z_L = 50\ \Omega$
Low noise operation point	S_{21}	–	17	–		$I_C = 6\text{ mA}$
High linearity operation point	S_{21}	–	19.5	–		$I_C = 25\text{ mA}$
Minimum noise figure					dB	$Z_S = Z_{opt}$
Minimum noise figure	NF_{min}	–	0.65	–		$I_C = 6\text{ mA}$
Associated gain	G_{ass}	–	17	–		$I_C = 6\text{ mA}$
Linearity					dBm	$Z_S = Z_L = 50\ \Omega$
1 dB gain compression point	OP_{1dB}	–	10	–		$I_C = 25\text{ mA}$
3rd order intercept point	OIP_3	–	24.5	–		$I_C = 25\text{ mA}$

Electrical Characteristics
Table 5-10 AC Characteristics, $V_{CE} = 3\text{ V}$, $f = 5.5\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Maximum power gain					dB	
Low noise operation point	G_{ms}	–	19	–		$I_C = 6\text{ mA}$
High linearity operation point	G_{ma}	–	20.5	–		$I_C = 25\text{ mA}$
Transducer gain					dB	$Z_S = Z_L = 50\ \Omega$
Low noise operation point	S_{21}	–	13.5	–		$I_C = 6\text{ mA}$
High linearity operation point	S_{21}	–	15.5	–		$I_C = 25\text{ mA}$
Minimum noise figure					dB	$Z_S = Z_{opt}$
Minimum noise figure	NF_{min}	–	0.8	–		$I_C = 6\text{ mA}$
Associated gain	G_{ass}	–	14.5	–		$I_C = 6\text{ mA}$
Linearity					dBm	$Z_S = Z_L = 50\ \Omega$
1 dB gain compression point	OP_{1dB}	–	10	–		$I_C = 25\text{ mA}$
3rd order intercept point	OIP_3	–	23.5	–		$I_C = 25\text{ mA}$

Table 5-11 AC Characteristics, $V_{CE} = 3\text{ V}$, $f = 10\text{ GHz}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Maximum power gain					dB	
Low noise operation point	G_{ma}	–	12.5	–		$I_C = 6\text{ mA}$
High linearity operation point	G_{ma}	–	14	–		$I_C = 25\text{ mA}$
Transducer gain					dB	$Z_S = Z_L = 50\ \Omega$
Low noise operation point	S_{21}	–	7	–		$I_C = 6\text{ mA}$
High linearity operation point	S_{21}	–	9	–		$I_C = 25\text{ mA}$
Minimum noise figure					dB	$Z_S = Z_{opt}$
Minimum noise figure	NF_{min}	–	1.45	–		$I_C = 6\text{ mA}$
Associated gain	G_{ass}	–	9	–		$I_C = 6\text{ mA}$
Linearity					dBm	$Z_S = Z_L = 50\ \Omega$
1 dB gain compression point	OP_{1dB}	–	8	–		$I_C = 25\text{ mA}$
3rd order intercept point	OIP_3	–	21	–		$I_C = 25\text{ mA}$

Notes

- $G_{ms} = |S_{21} / S_{12}|$ for $k < 1$; $G_{ma} = |S_{21} / S_{12}|(k - (k^2 - 1)^{1/2})$ for $k > 1$
- In order to get the NF_{min} values stated in this chapter the test fixture losses have been subtracted from all measured results.
- OIP_3 value depends on termination of all intermodulation frequency components. Termination used for this measurement is $50\ \Omega$ from 0.2 MHz to 12 GHz .

5.4 Characteristic DC Diagrams

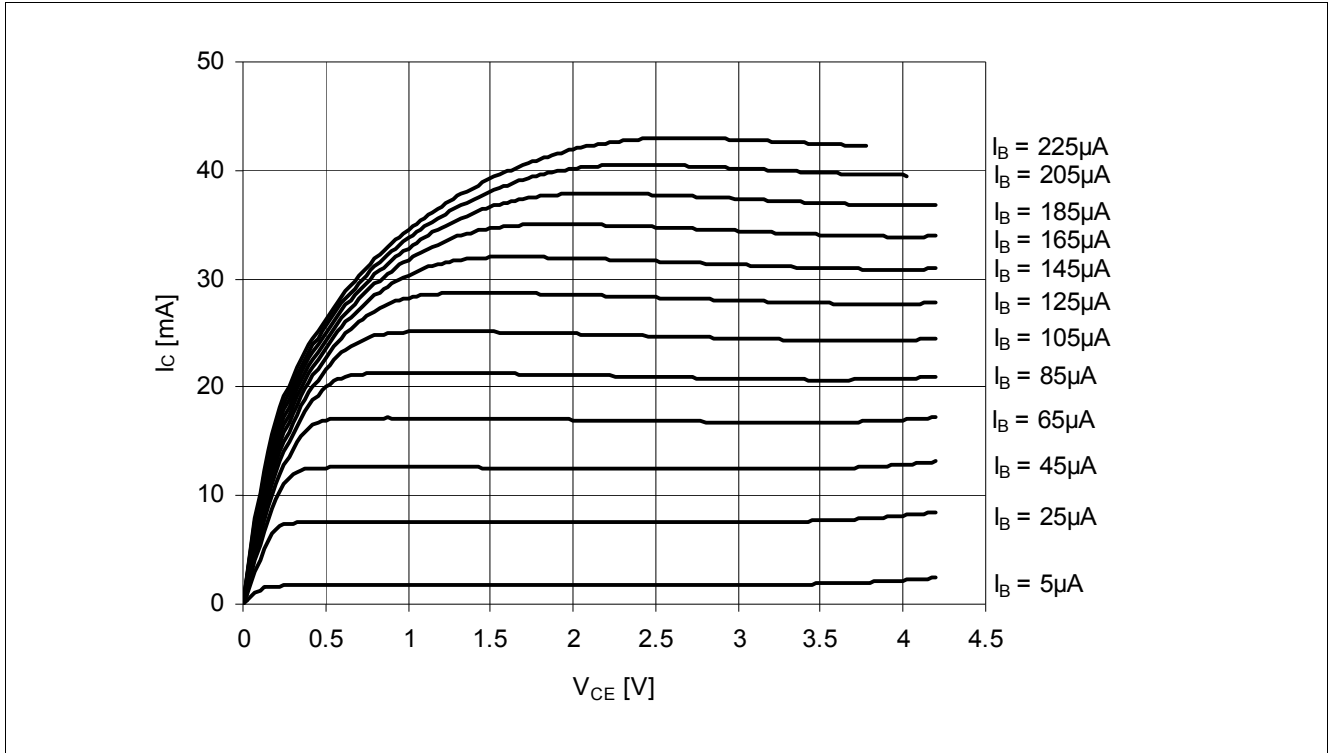


Figure 5-2 Collector Current vs. Collector Emitter Voltage $I_C = f(V_{CE})$, $I_B = \text{Parameter in } \mu\text{A}$

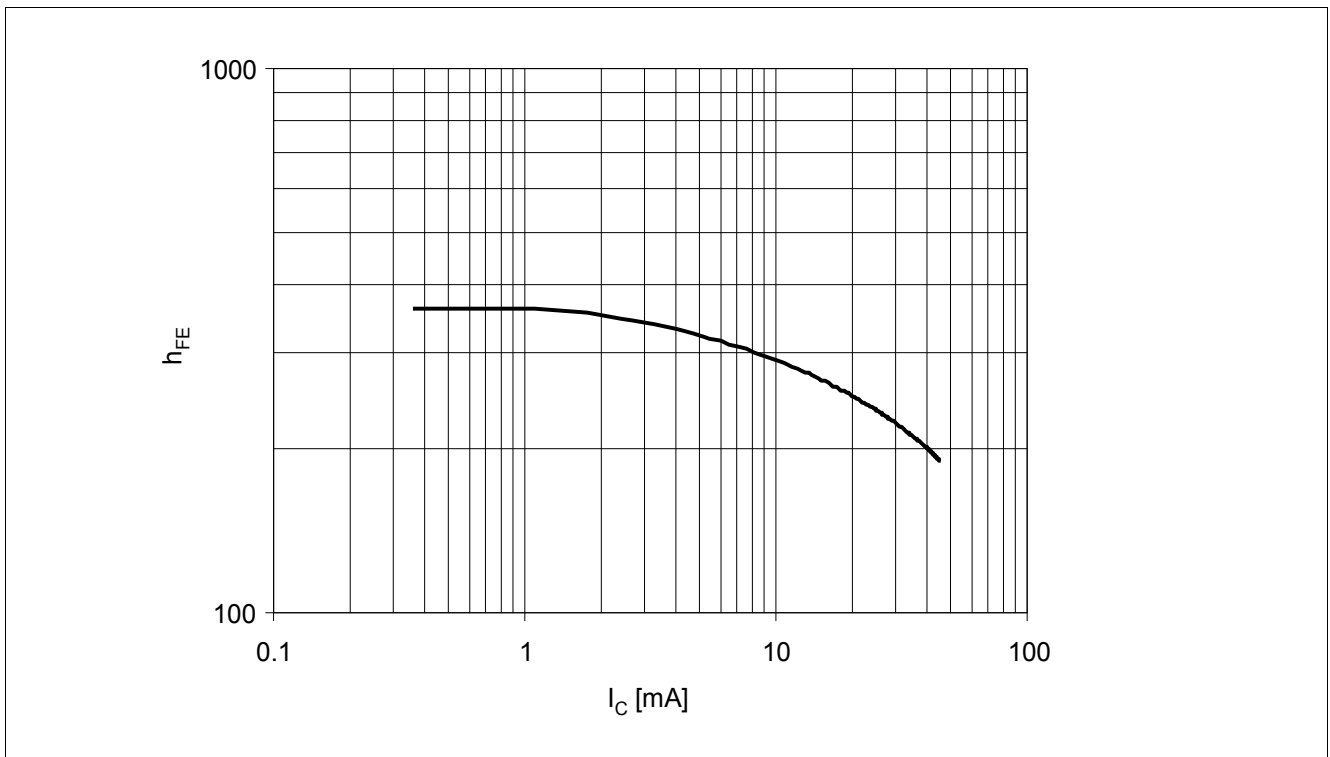


Figure 5-3 DC Current Gain $h_{FE} = f(I_C)$, $V_{CE} = 3 \text{ V}$

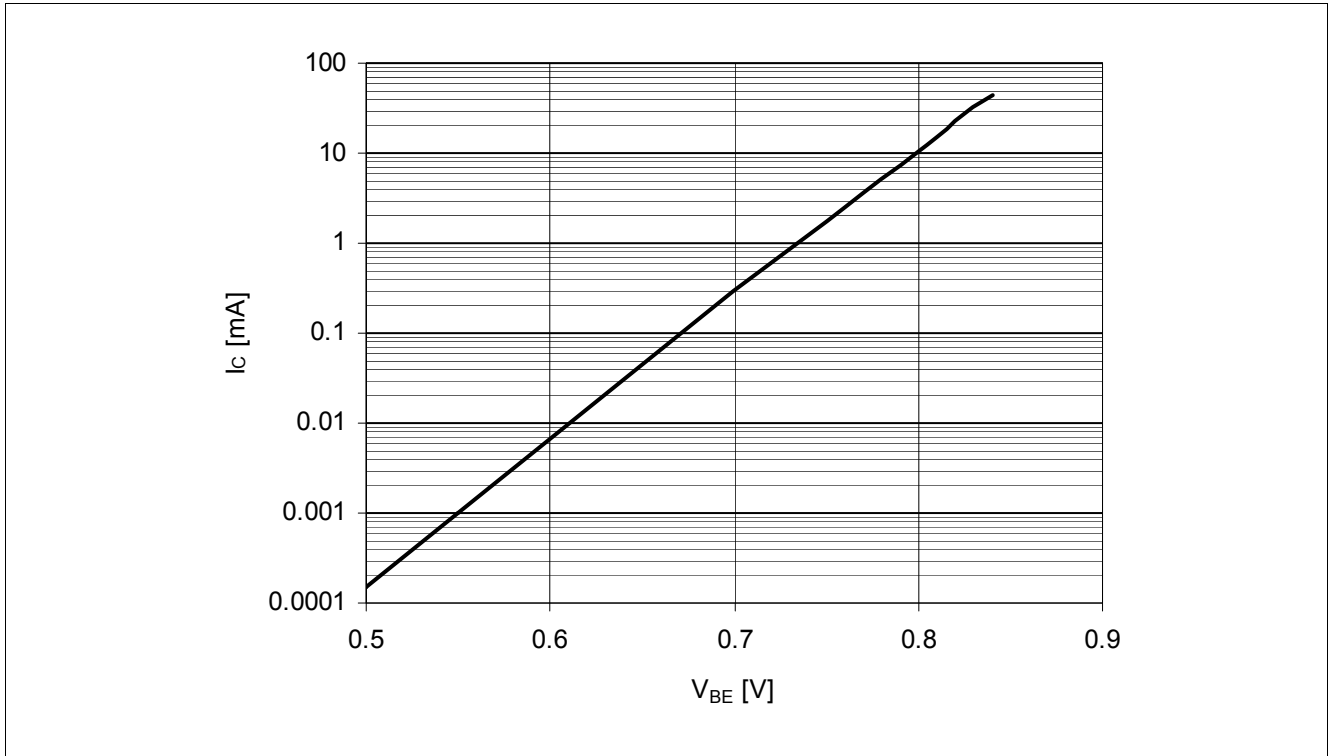


Figure 5-4 Collector Current vs. Base Emitter Voltage $I_C = f(V_{BE})$, $V_{CE} = 2\text{ V}$

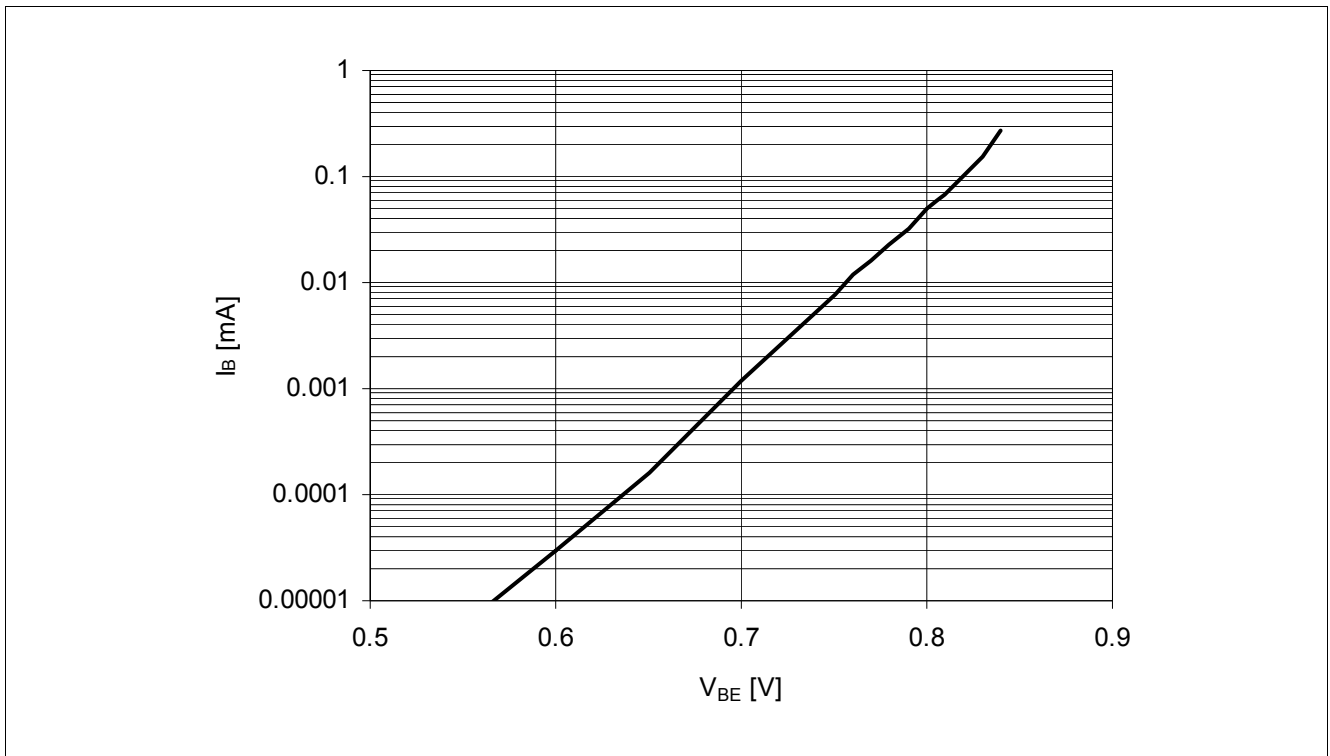


Figure 5-5 Base Current vs. Base Emitter Forward Voltage $I_B = f(V_{BE})$, $V_{CE} = 2\text{ V}$

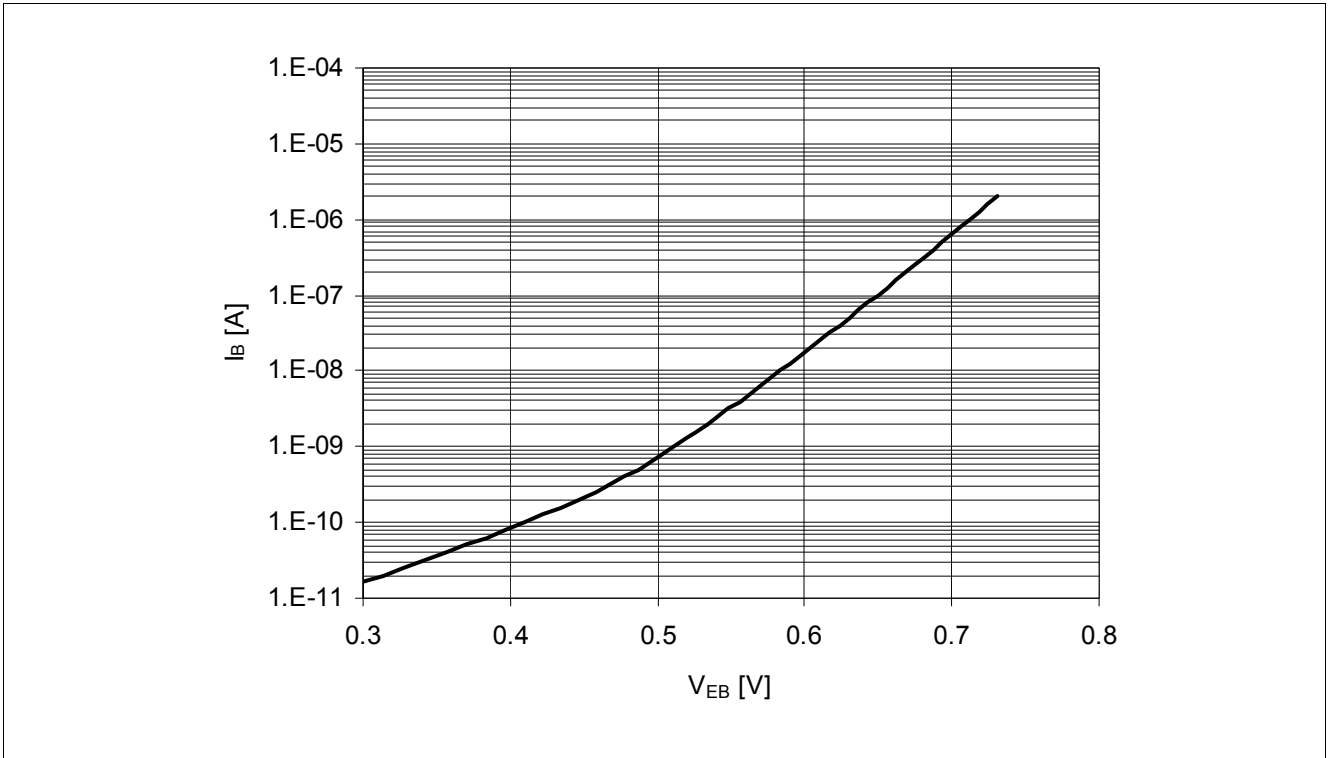


Figure 5-6 Base Current vs. Base Emitter Reverse Voltage $I_B = f(V_{EB})$, $V_{CE} = 2\text{ V}$

5.5 Characteristic AC Diagrams

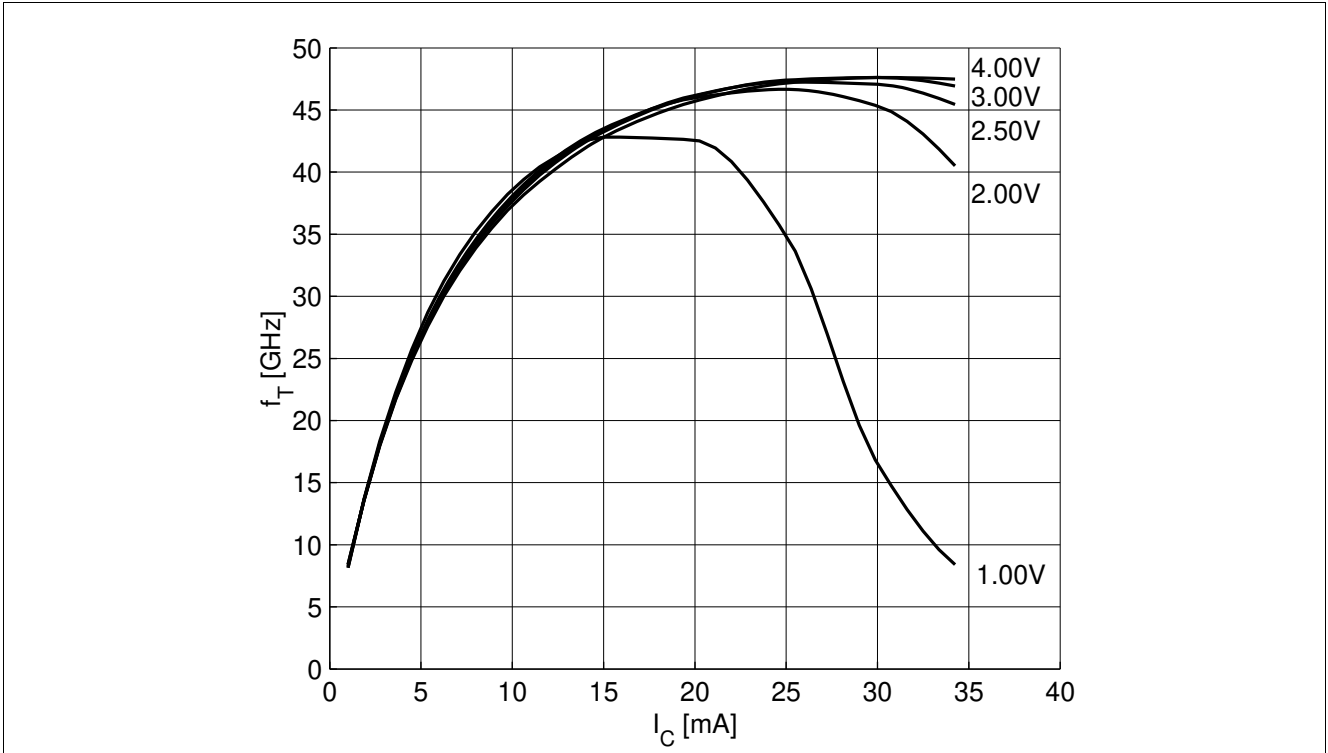


Figure 5-7 Transition Frequency $f_T = f(I_C)$, $f = 1 \text{ GHz}$, $V_{CE} = \text{Parameter in V}$

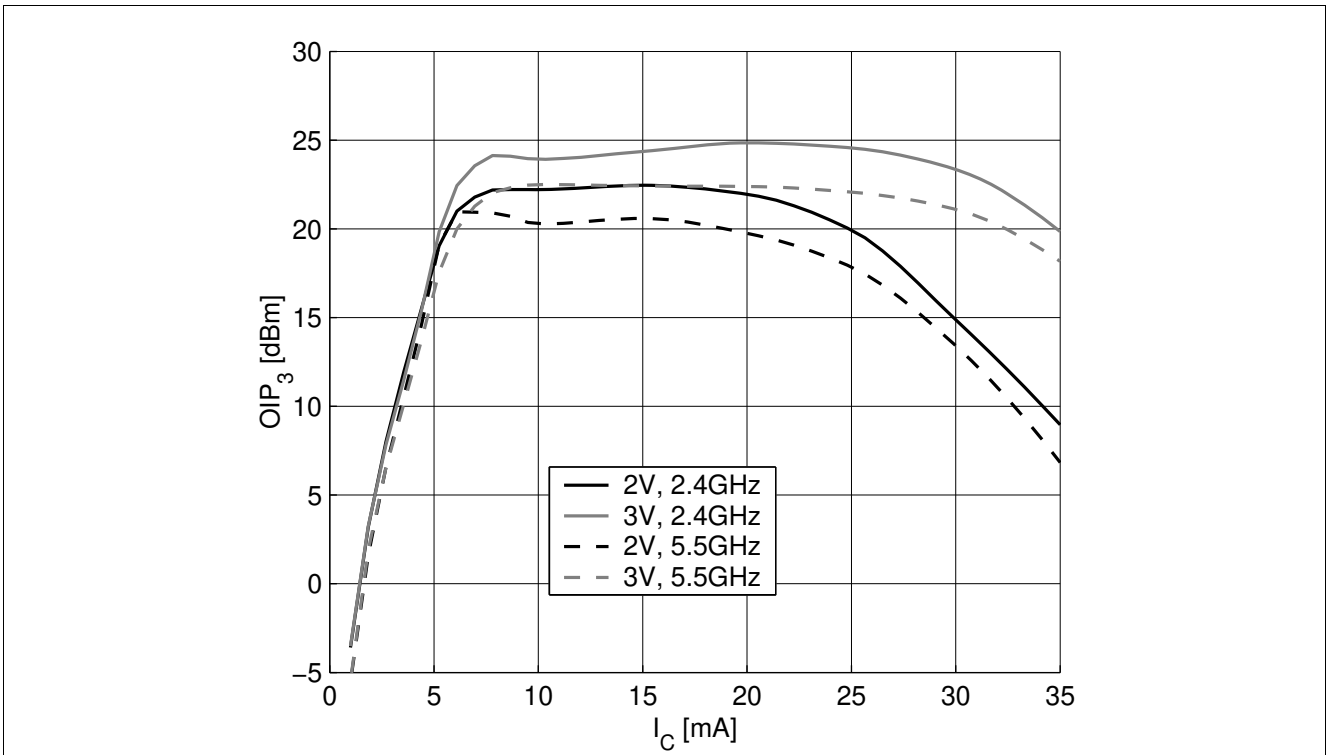


Figure 5-8 3rd Order Intercept Point $OIP_3 = f(I_C)$, $Z_S = Z_L = 50 \Omega$, $V_{CE}, f = \text{Parameters}$

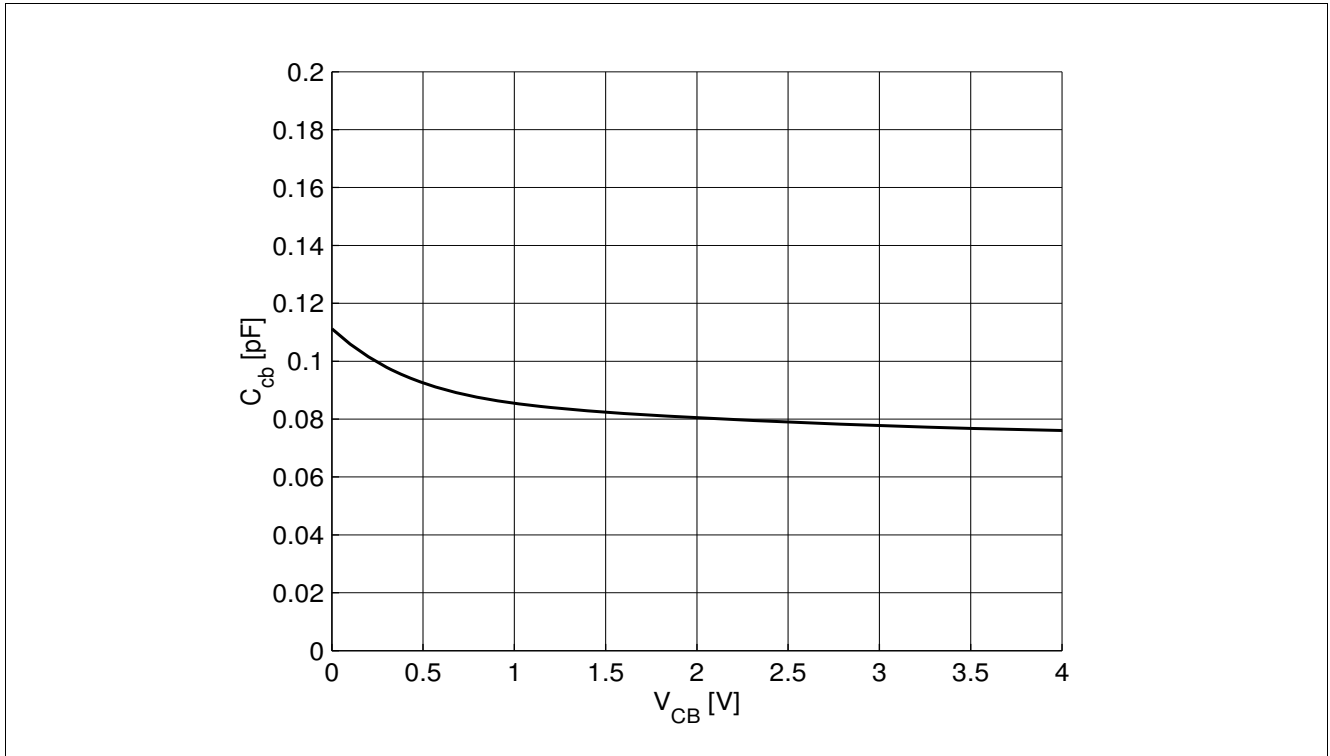


Figure 5-9 Collector Base Capacitance $C_{CB} = f(V_{CB}), f = 1 \text{ MHz}$

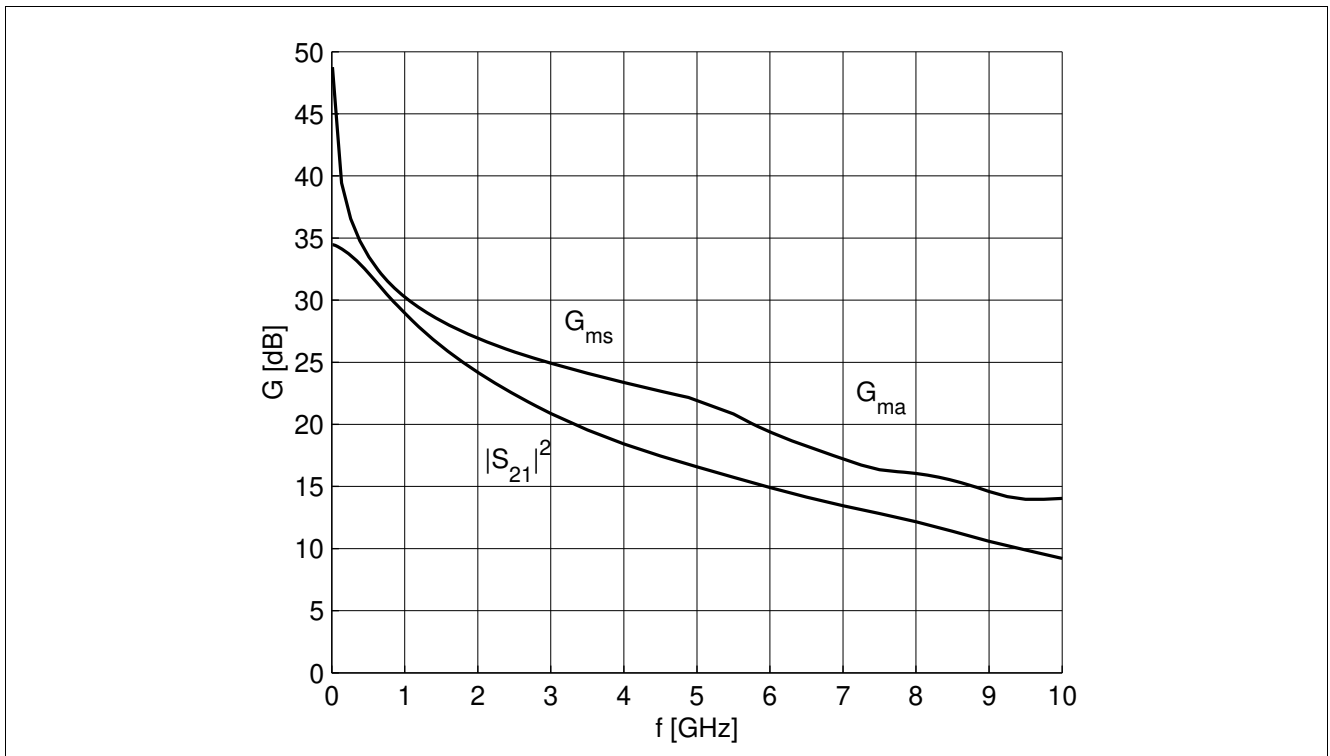


Figure 5-10 Gain $G_{ma}, G_{ms}, |S_{21}|^2 = f(f), V_{CE} = 3 \text{ V}, I_C = 25 \text{ mA}$

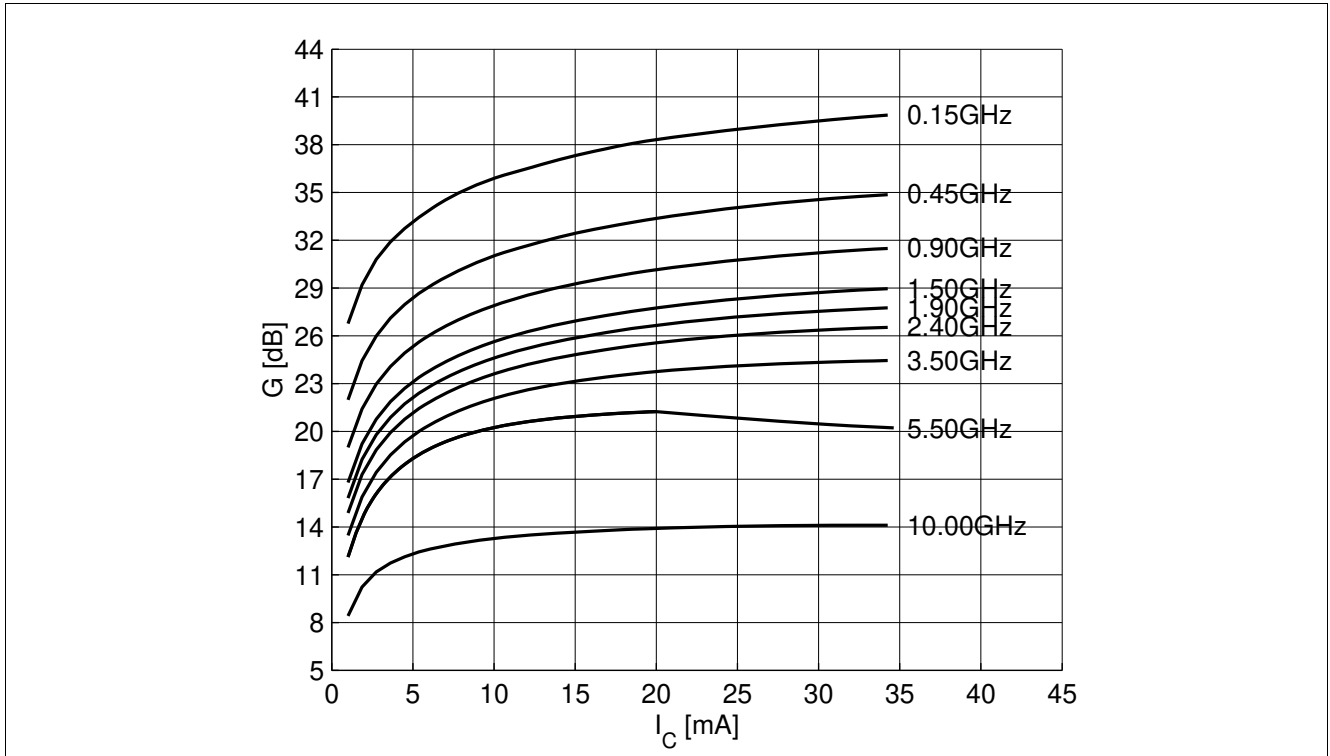


Figure 5-11 Maximum Power Gain $G_{max} = f(I_C)$, $V_{CE} = 3\text{ V}$, $f = \text{Parameter in GHz}$

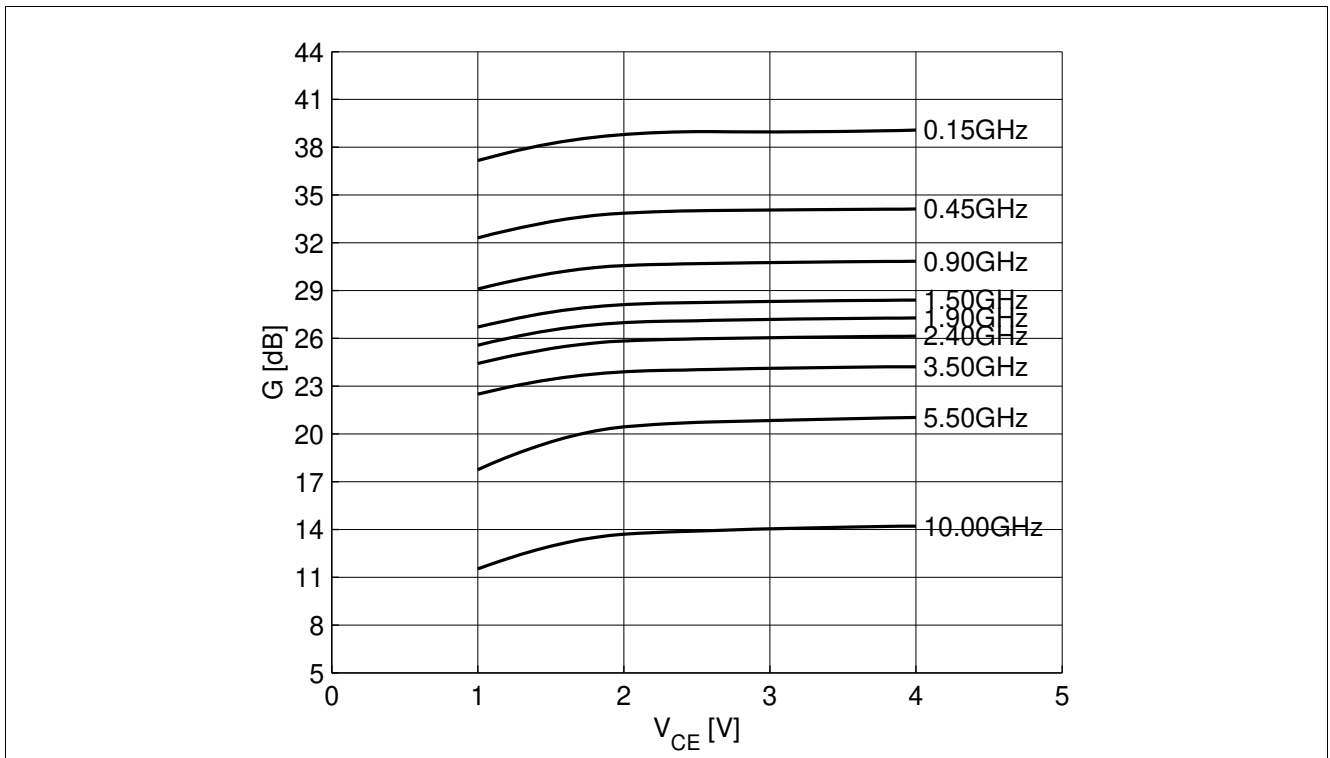


Figure 5-12 Maximum Power Gain $G_{max} = f(V_{CE})$, $I_C = 25\text{ mA}$, $f = \text{Parameter in GHz}$

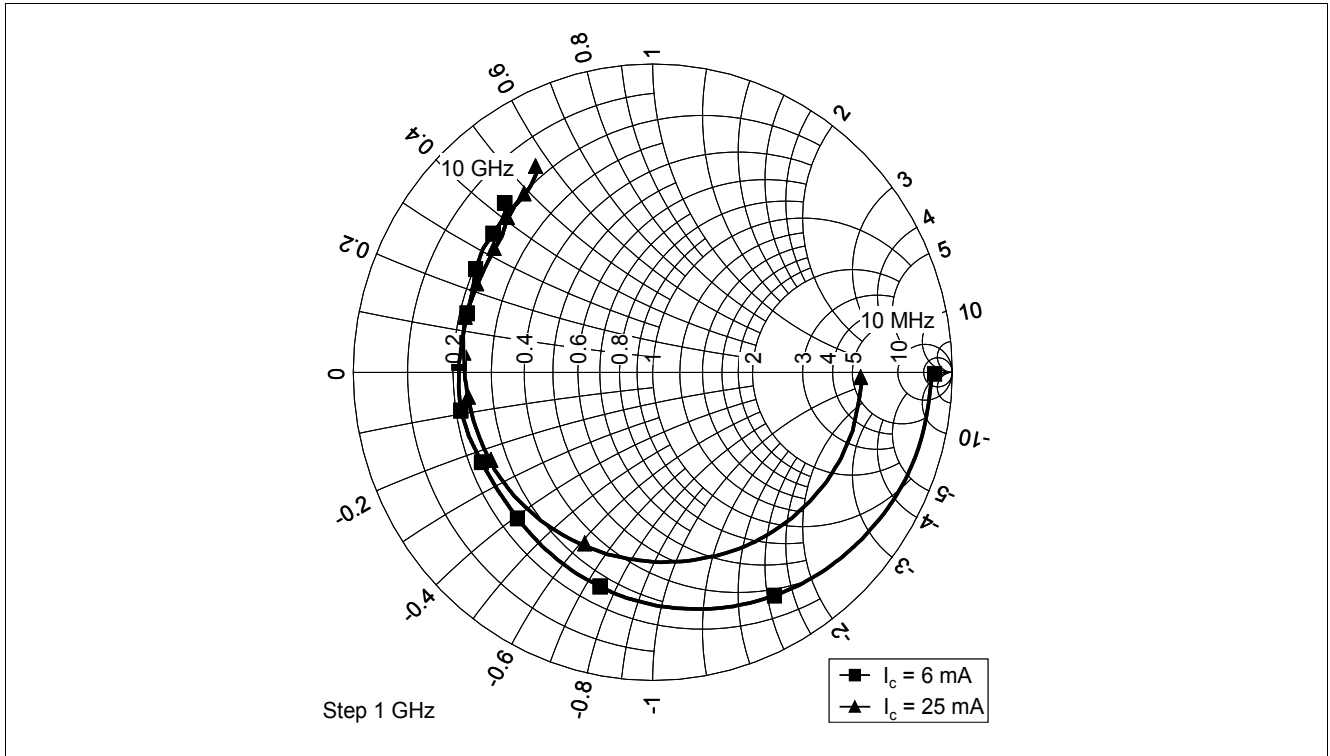


Figure 5-13 Input Matching $S_{11} = f(f)$, $V_{CE} = 3\text{ V}$, $I_C = 6 / 25\text{ mA}$

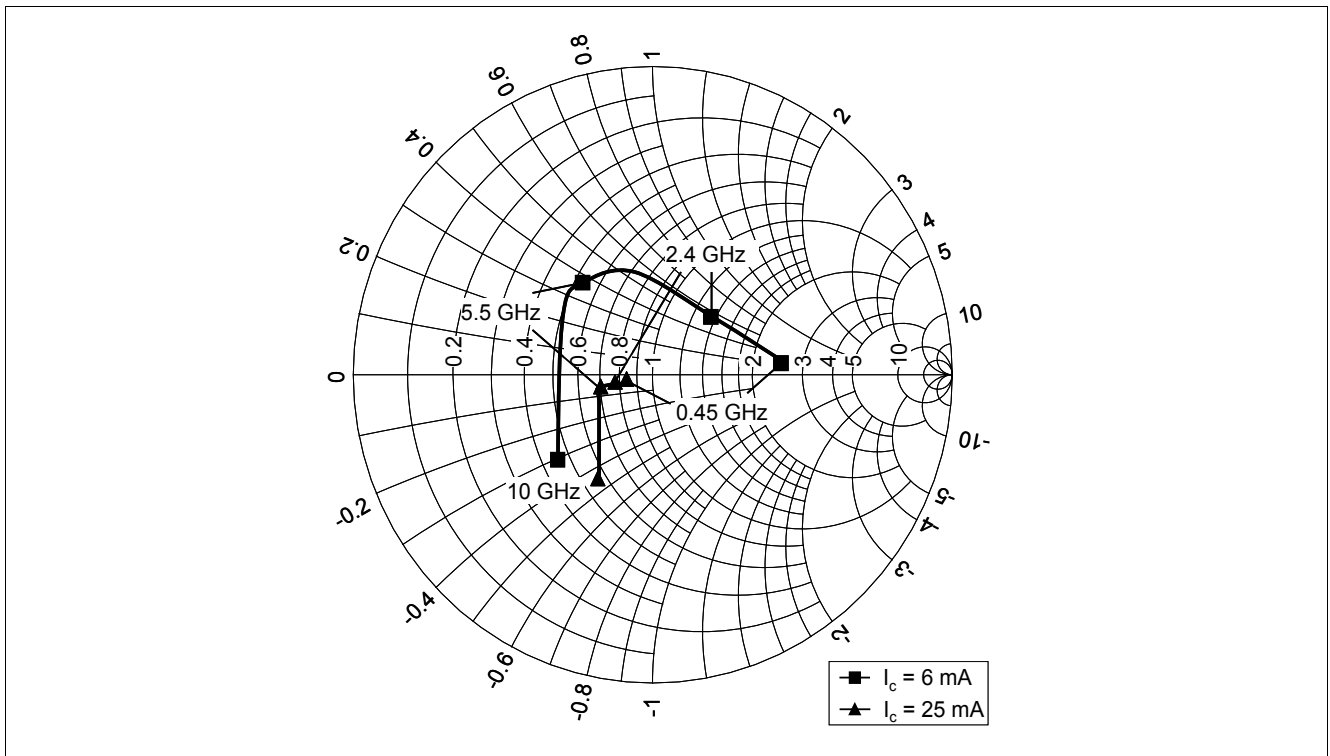


Figure 5-14 Source Impedance for Minimum Noise Figure $Z_{opt} = f(f)$, $V_{CE} = 3\text{ V}$, $I_C = 6 / 25\text{ mA}$

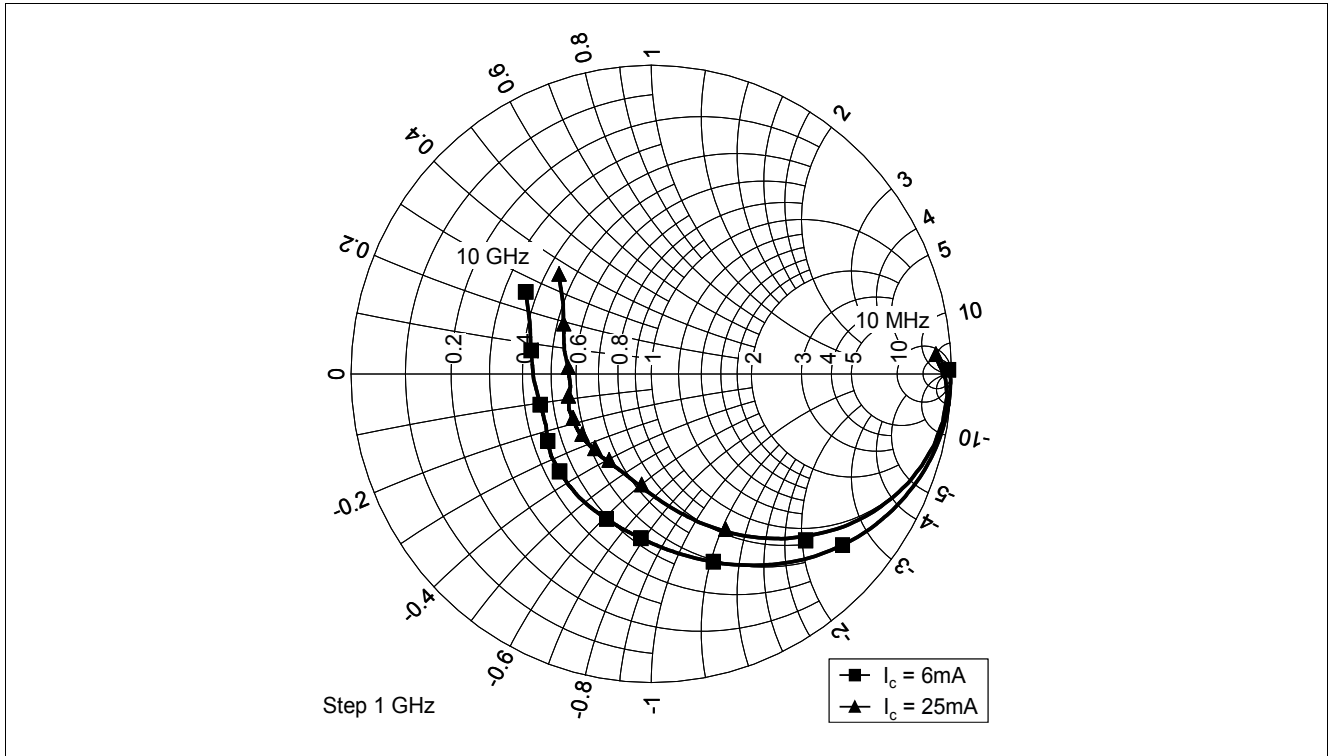


Figure 5-15 Output Matching $S_{22} = f(f)$, $V_{CE} = 3\text{ V}$, $I_C = 6 / 25\text{ mA}$

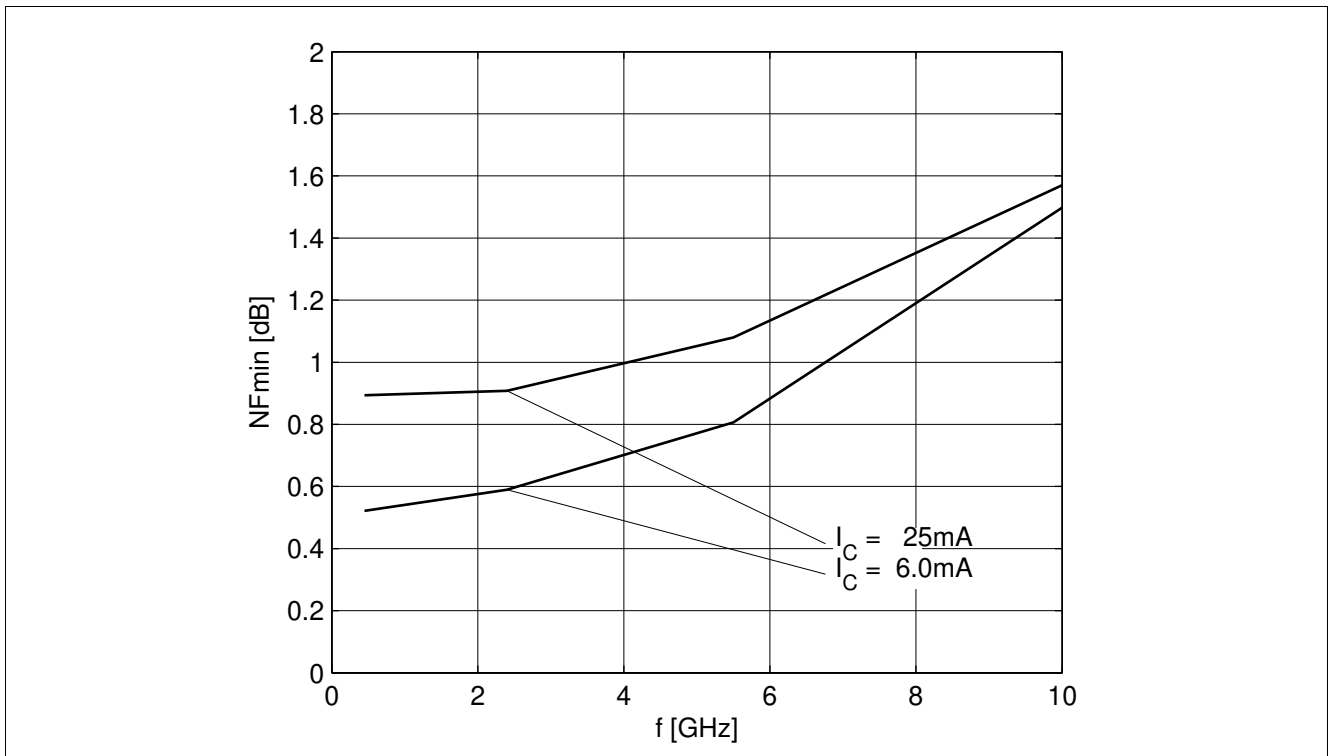


Figure 5-16 Noise Figure $NF_{min} = f(f)$, $V_{CE} = 3\text{ V}$, $I_C = 6 / 25\text{ mA}$, $Z_S = Z_{opt}$

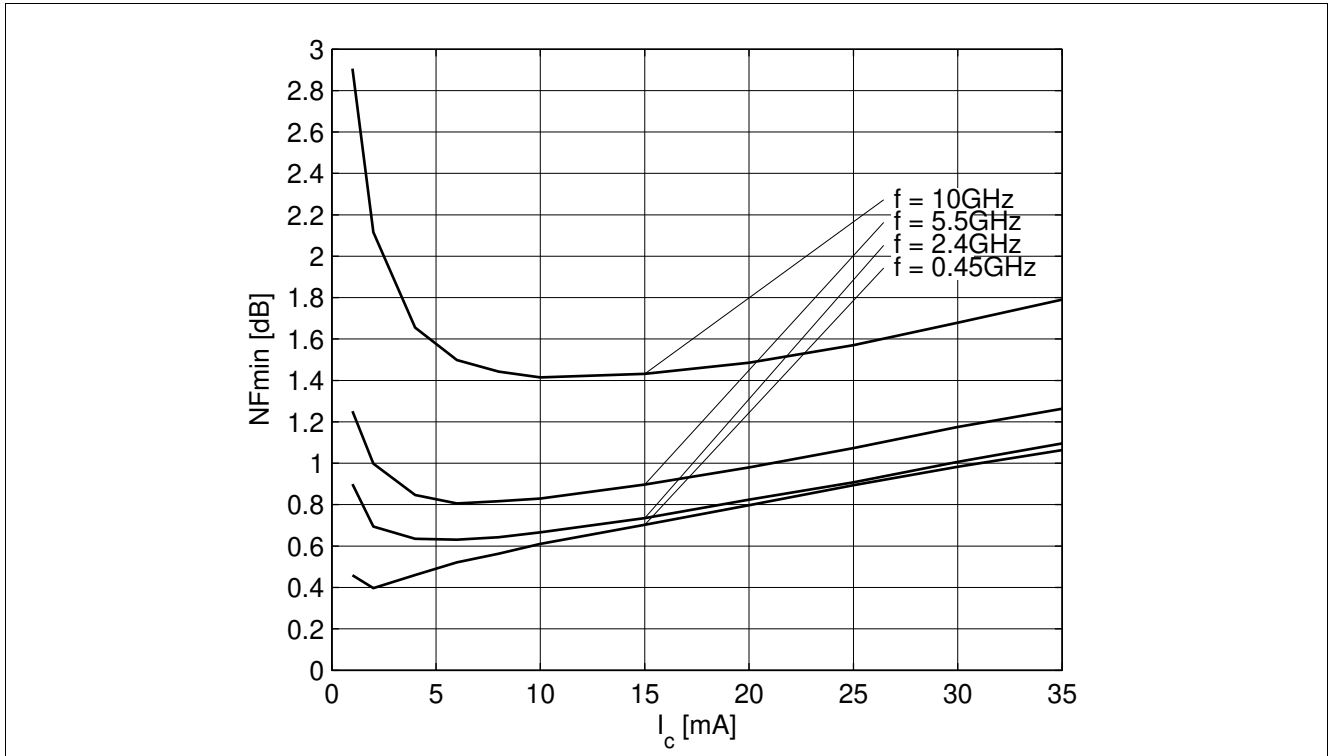


Figure 5-17 Noise Figure $NF_{min} = f(I_C)$, $V_{CE} = 3\text{ V}$, $Z_S = Z_{opt}$, $f = \text{Parameter in GHz}$

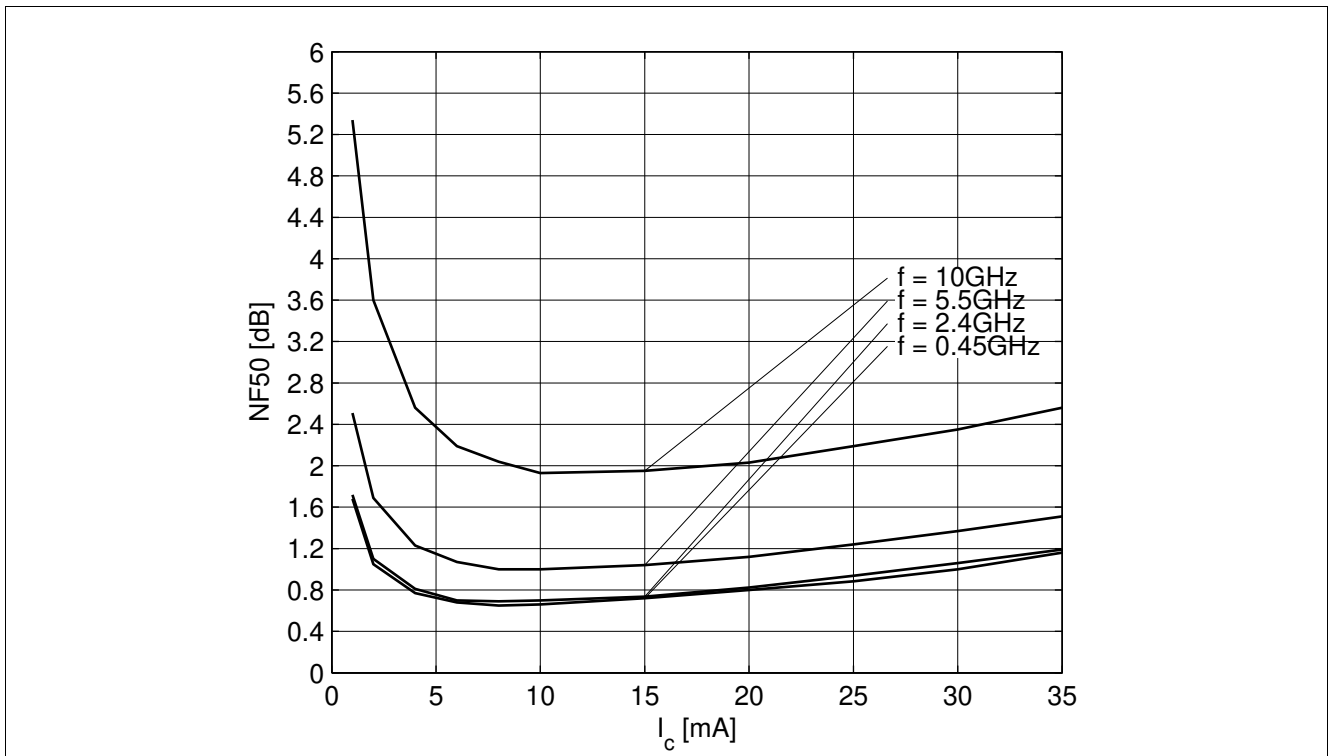


Figure 5-18 Noise Figure $NF_{50} = f(I_C)$, $V_{CE} = 3\text{ V}$, $Z_S = 50\ \Omega$, $f = \text{Parameter in GHz}$

Note: The curves shown in this chapter have been generated using typical devices but shall not be considered as a guarantee that all devices have identical characteristic curves. $T_A = 25\text{ }^\circ\text{C}$